Sheet 1 of 1

Form PTO-1449 US Dept. of Commerce (REV. 1/06) US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT					ATTY DOCKET NO. 127425			APPLICATION NO. 10/572,904				
(Use several sheets if necessary)					APPLICANT(S) Tomohiro SHINAGAWA et al.							
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Sheet of 1 Form PTO-1449 US Dept. of Commerce ATTY DOCKET NO. APPLICATION NO. PATENT & TRADEMARK OFFICE 127425 New U.S. National Stage (REV. 1/06) of PCT/JP2004/015104 INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) **APPLICANTS** Tomohiro SHINAGAWA et al. **FILING DATE** March 21, 2006 **U.S. PATENT DOCUMENTS** Cite Examiner Initials No. Document Number Date Name /HA/ 1/4/1994 COFFINBERRY ET AL. 1. US 5,275,000 /HA/ 2. US 5,373,818 12/20/1994 **UNGER** /HA/ QIAN ET AL. 3. US 2003/0168024 A1 9/11/2003 FOREIGN PATENT DOCUMENTS With With Cite Examiner Initials No. Document Number Date Country English English Abstract Translation /HA/ 4. JP A 2000-297706 10/24/2000 **JAPAN** Х Х Х /HA/ 5. JP A 2002-255503 9/11/2002 **JAPAN** х /HA/ 7/5/1989 **JAPAN** Х JP A 1-170752 6. JP B2 3-9091 2/7/1991 **JAPAN** Х /HA/ 7. /HA/ 8. JP B2 5-18761 3/12/1993 **JAPAN** Х /HA/ 9. JP A 2001-110437 4/20/2001 **JAPAN** X Х Х Х 6/7/1994 **JAPAN** /HA/ 10. JP A 6-159096 /HA/ 7/3/2003 **JAPAN** Х X JP A 2003-184667 11. х 12. JP A 2000-213444 8/2/2000 **JAPAN** Х /HA/ OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) Examiner Cite Initials No. DATE CONSIDERED 01/08/2008 **EXAMINER** /Hyder Ali/

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